

Search Notes

Application/Control No.

10/627,216

Examiner

Nhan T. Tran

Applicant(s)/Patent under
Reexamination

HAGIWARA, AKIRA

Art Unit

2622

SEARCHED

Class	Subclass	Date	Examiner
348	211.99	7/16/2007	NT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB)	7/16/2007	NT
Text search classes 348, 378 and 705 (see search history printout)	7/16/2007	NT